

# Use Tag & Probe method to measure electron efficiency

Group 9

iSTEP-2016

2016 年 7 月 20 日

# Outline

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- electron detection
  - ▶ in many physics processes at LHC, electron is an important signature
  - ▶ electron can be detected accurately in tracker and calorimeter
- electron efficiency
  - ▶ probability that a electron is detected by the detector and used to predict total electrons based on observed electrons
  - ▶ bias sources: trigger inefficiency, misidentified hadrons(jet), photon conversions, non-isolated electrons from heavy-flavors decays.
  - ▶ efficiency factor:  $C = \epsilon_{event} \cdot \alpha_{reco} \cdot \epsilon_{ID} \cdot \epsilon_{trig} \cdot \epsilon_{isol}$

# Method: Tag and Probe

- the dilepton decays of some particles are the best choices for lepton efficiency measurement like Z boson,  $J/\psi$ ,  $\Upsilon$  ...
- choose one lepton passed selection call Tag, the other one is Probe without any selection.
- the total Probe lepton Number:  $N_{probe\_total}$ , the number of probe pass selection:  $N_{probe+pass}$

leg1	leg2	comments
pass	pass	selected
pass	fail	selected
fail	pass	selected
fail	fail	Not selected

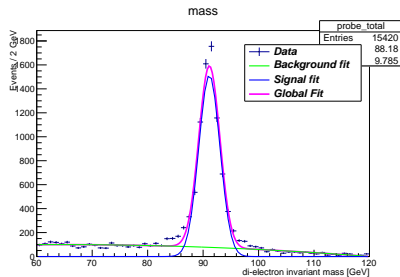
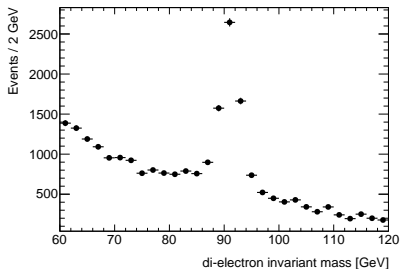
- corresponding efficiency:

$$\epsilon = \frac{N_{probe+pass}}{N_{probe\_total}}$$

- sample used: mixed Zee(Signal)+Dijet(Background) samples
- background subtraction:
  - ▶  $N_{leptons} = 2$  , Opposite Charge.
  - ▶ the criteria for ID used in Tag and Probe.  
probability of jet misidentified as electron pretty low.
  - ▶ exclude background by fitting.
- improve statistics
  - ▶ select tag electron randomly, every event used twice

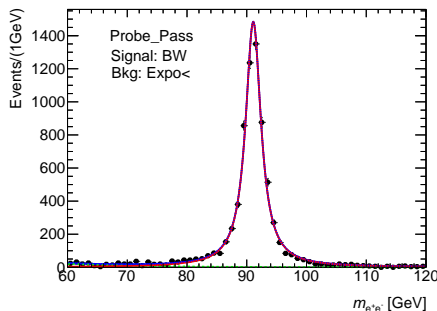
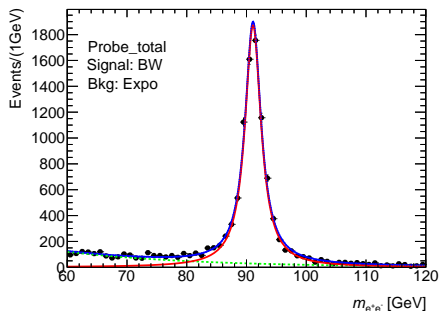
# Fitting Strategy

- the shape: a Gaussian-like peak and a expo-like background.
- fit Model: Signal: Breit-Wigner/Gaussian  
Bkg: Expo./2nd Polynomial.
- Bkg fit: set two separate range [60, 70] GeV and [110, 120] GeV to make bkg template



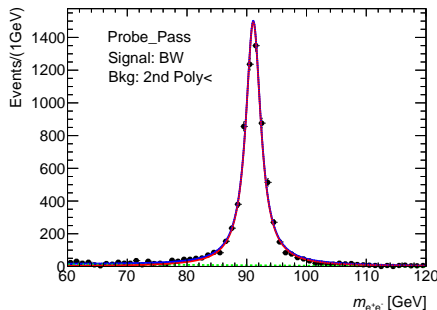
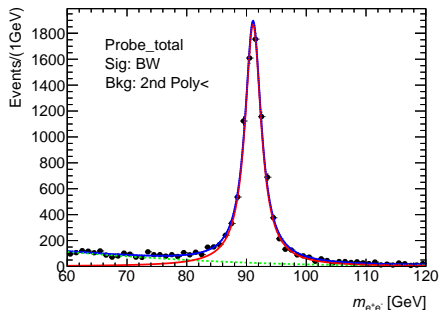
# Fitting Results(1)

- Signal: Breit-Wigner Bkg: Expo.
- probe total(left):  $\chi^2/\text{ndof} = 2.65$  probe pass(right):  $\chi^2/\text{ndof} = 2.67$
- after bkg subtraction: left: 9265.55; right: 7065.71
- $\text{eff} = 0.763 \pm 0.004(\text{stat.})$



## Fitting Results(2)

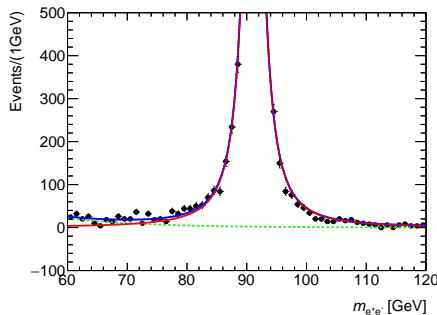
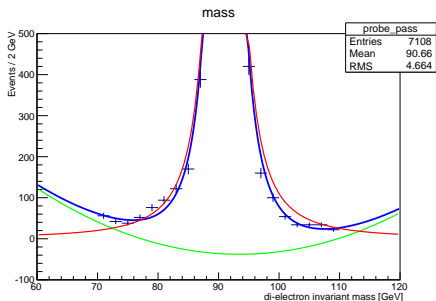
- Signal: Breit-Wigner Bkg: 2nd Poly.
- probe total(left):  $\chi^2/\text{ndof} = 2.53$  probe pass(right):  $\chi^2/\text{ndof} = 2.96$
- after bkg subtraction: left: 9300.67; right: 6915.88
- $\text{eff} = 0.744 \pm 0.005(\text{stat.})$





# Fitting Results(3)

- BW+quaridiac model(left), BW+exponential model(right)



the BW+quaridiac model may have problems in fitting the peak region.  
choose the BW+exponential model as the main model.

# Uncertainty(1)

- Statistics Uncertainties

Every experiment is a Bernoulli distribution, the probability of the  $n$  times experiments:  $P(X) = C_n^x p^x (1-p)^{n-x}$ ,  $q = 1-p$

Expectation:  $\bar{x} = np$     Variance:  $v(x) = npq$

Efficiency:

$$\epsilon = \frac{N_{probe+pass}}{N_{probe\_total}}$$

Statistics Uncertainties:

$$\sigma_\epsilon = \sqrt{N_{probe\_total} \epsilon (1-\epsilon) / N_{probe\_total}} = \sqrt{\epsilon (1-\epsilon) / N_{probe\_total}}$$

# Uncertainty(2)

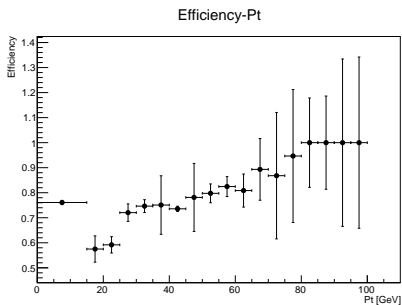
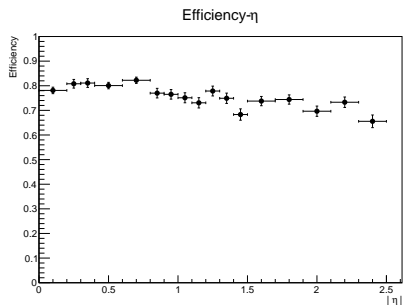
- Systematic Uncertainties

- ▶ internal systematic in model: from the errors of parameters
- ▶ model vs model: alternative model:  $\text{signal(B-W function)} + \text{background(quadratic model)}$
- ▶ The size of signal window
- ▶ Other possible observed bias...

- for Integral Region:  $\text{eff} = 0.763 \pm 0.004(\text{stat.}) \pm 0.022(\text{syst.})$

# eff-eta & eff-pt

calculate the efficiency in different eta and pt bins.



# Summary & Outlook

- Summary

Be familiar with the ROOT software & Tag and Probe Method;  
Study the electron efficiency of Zee.

- Outlook





more available statistic;  
more accurate fit function;  
separate MC sample for Zee and Dijet;  
more variables...

# Contribution list

LiBingzhi(SJTU),ChenQian(PKU),HanKunlin(USTC)  
SheZhilei(CUG),LiHongqiang(SNNU),HeYangle(HNU)



# References

-  ATLAS Collaboration, Electron performance measurements with the ATLAS detector using the 2010 LHC proton-proton collision data, arXiv:1110.3174.
-  ATLAS Collaboration, Electron reconstruction and identification efficiency measurements with the ATLAS detector using the 2011 LHC proton-proton collision data, arXiv:1404.2240v3.
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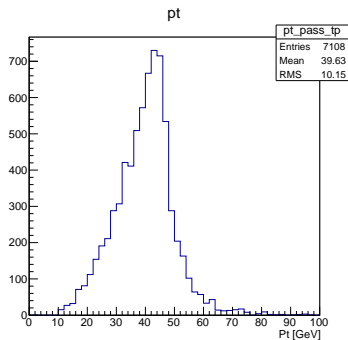
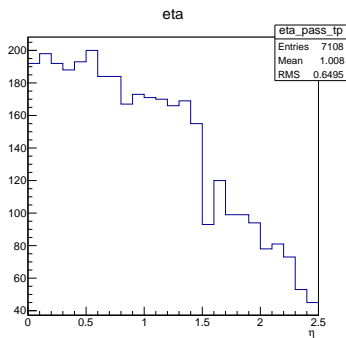
# Acknowledgements

- Thanks for the guidance and help from Prof. Ning Zhou and Prof. Huaqiao Zhang;
- Best wishes for all the professors and classmates of iSTEP;
- Thanks for your attention!



# Backup(1)

the pt and eta distributions for *probe<sub>p</sub>pass* electron



# Backup(2)

	eta	Efficiency	statistical error	systematic error	
Nbin: 1	range: 0 — 0.2	eff: 0.781065	err: 0.0131335	serr: 0.021606	
Nbin: 2	range: 0.2 — 0.3	eff: 0.80808	err: 0.0176053	serr: 0.0285407	
Nbin: 3	range: 0.3 — 0.4	eff: 0.811005	err: 0.0176868	serr: 0.0283485	
Nbin: 4	range: 0.4 — 0.6	eff: 0.800729	err: 0.013079	serr: 0.0265342	
Nbin: 5	range: 0.6 — 0.8	eff: 0.822268	err: 0.0126991	serr: 0.0235423	
Nbin: 6	range: 0.8 — 0.9	eff: 0.769998	err: 0.0194462	serr: 0.032396	
Nbin: 7	range: 0.9 — 1	eff: 0.765147	err: 0.0194461	serr: 0.0242351	
Nbin: 8	range: 1 — 1.1	eff: 0.751179	err: 0.0203361	serr: 0.0272443	
Nbin: 9	range: 1.1 — 1.2	eff: 0.730704	err: 0.0208984	serr: 0.0322832	
Nbin: 10	range: 1.2 — 1.3	eff: 0.778582	err: 0.0199412	serr: 0.0354229	
Nbin: 11	range: 1.3 — 1.4	eff: 0.749146	err: 0.0209612	serr: 0.0349767	
Nbin: 12	range: 1.4 — 1.5	eff: 0.683085	err: 0.0230703	serr: 0.0338697	
Nbin: 13	range: 1.5 — 1.7	eff: 0.737726	err: 0.0188363	serr: 0.0319835	
Nbin: 14	range: 1.7 — 1.9	eff: 0.744096	err: 0.0188303	serr: 0.0309326	
Nbin: 15	range: 1.9 — 2.1	eff: 0.696597	err: 0.0208794	serr: 0.0294867	
Nbin: 16	range: 2.1 — 2.3	eff: 0.73305	err: 0.0212604	serr: 0.0273563	
Nbin: 17	range: 2.3 — 2.5	eff: 0.655548	err: 0.0257066	serr: 0.104211	

# Backup(3)

	PT	Efficiency	: statistical	error	: systematic	error			
Nbin:	1	range:	0 — 15	eff:	0.759576	err:	0.0174502	serr:	0.0284194
Nbin:	2	range:	15 — 20	eff:	0.793843	err:	0.015912	serr:	0.0219019
Nbin:	3	range:	20 — 25	eff:	0.808261	err:	0.0159702	serr:	0.026741
Nbin:	4	range:	25 — 30	eff:	0.782414	err:	0.0167504	serr:	0.0256149
Nbin:	5	range:	30 — 35	eff:	0.843759	err:	0.0155366	serr:	0.0399394
Nbin:	6	range:	35 — 40	eff:	0.814429	err:	0.0159163	serr:	0.0303071
Nbin:	7	range:	40 — 45	eff:	0.75523	err:	0.0175729	serr:	0.0259772
Nbin:	8	range:	45 — 50	eff:	0.797548	err:	0.0169506	serr:	0.025292
Nbin:	9	range:	50 — 55	eff:	0.754308	err:	0.0178253	serr:	0.0241767
Nbin:	10	range:	55 — 60	eff:	0.750114	err:	0.0189108	serr:	0.0320689
Nbin:	11	range:	60 — 65	eff:	0.754763	err:	0.0185574	serr:	0.0287558
Nbin:	12	range:	65 — 70	eff:	0.718455	err:	0.0196301	serr:	0.031854
Nbin:	13	range:	70 — 75	eff:	0.781691	err:	0.0228375	serr:	0.0407119
Nbin:	14	range:	75 — 80	eff:	0.663948	err:	0.0249841	serr:	0.0381147
Nbin:	15	range:	80 — 85	eff:	0.759617	err:	0.0239329	serr:	0.0357574
Nbin:	16	range:	85 — 90	eff:	0.694938	err:	0.025467	serr:	0.0307754
Nbin:	17	range:	90 — 95	eff:	0.691467	err:	0.0268193	serr:	0.0434172
Nbin:	18	range:	95 — 100	eff:	0.678689	err:	0.02727	serr:	0.0215287